## Small Signal Diodes



## FEATURES

- Silicon Epitaxial Planar Diode
- Fast switching diode.
- This diode is also available in other case styles including: the SOD-123 case with the type designation 1N4448W, the MiniMELF case with the type designation LL4448, and the SOT23 case with the type designation IMBD4448.


## MECHANICAL DATA

Case: DO-35 Glass Case
Weight: approx. 0.13 g

## MAXIMUM RATINGS AND ELECTRICAL CHARACTERISTICS

Ratings at $25^{\circ} \mathrm{C}$ ambient temperature unless otherwise specified

|  | Symbol | Value | Unit |
| :--- | :--- | :--- | :--- |
| Reverse Voltage | $\mathrm{V}_{\mathrm{R}}$ | 75 | V |
| Peak Reverse Voltage | $\mathrm{V}_{\mathrm{RM}}$ | 100 | V |
| Rectified Current (Average) <br> Half Wave Rectification with Resist. Load <br> at $T_{\text {amb }}=25^{\circ} \mathrm{C}$ and $\mathrm{f} \geq 50 \mathrm{~Hz}$ | $\mathrm{I}_{0}$ | $150^{1)}$ | mA |
| Surge Forward Current at $\mathrm{t}<1 \mathrm{~s}$ and $\mathrm{T}_{\mathrm{j}}=25^{\circ} \mathrm{C}$ |  |  |  |
| Power Dissipation at $\mathrm{T}_{\text {amb }}=25^{\circ} \mathrm{C}$ | $\mathrm{I}_{\mathrm{FSM}}$ | 500 | mA |
| Junction Temperature | $\mathrm{P}_{\text {tot }}$ | $500^{1)}$ | mW |
| Storage Temperature Range | $\mathrm{T}_{\mathrm{j}}$ | 175 | ${ }^{\circ} \mathrm{C}$ |
| 1) Valid provided that leads at a distance of 8 mm from case are kept at ambient temperature. | ${ }^{\circ} \mathrm{C}$ |  |  |

## 1N4448

## ELECTRICAL CHARACTERISTICS

Ratings at $25^{\circ} \mathrm{C}$ ambient temperature unless otherwise specified

|  | Symbol | Min. | Typ. | Max. | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: |
| Forward Voltage at $I_{F}=5 \mathrm{~mA}$ <br> at $\mathrm{I}_{\mathrm{F}}=10 \mathrm{~mA}$ | $\begin{aligned} & V_{F} \\ & V_{F} \end{aligned}$ | $0.62$ | - | $\begin{aligned} & 0.72 \\ & 1 \end{aligned}$ | V |
| Leakage Current <br> at $\mathrm{V}_{\mathrm{R}}=20 \mathrm{~V}$ <br> at $V_{R}=75 \mathrm{~V}$ <br> at $\mathrm{V}_{\mathrm{R}}=20 \mathrm{~V}, \mathrm{~T}_{\mathrm{j}}=150^{\circ} \mathrm{C}$ | $\begin{aligned} & I_{R} \\ & I_{R} \\ & I_{R} \end{aligned}$ | - | - | $\begin{aligned} & 25 \\ & 5 \\ & 50 \end{aligned}$ | $\begin{aligned} & \mathrm{nA} \\ & \mu \mathrm{~A} \\ & \mu \mathrm{~A} \end{aligned}$ |
| Reverse Breakdown Voltage tested with $100 \mu \mathrm{~A}$ Pulses | $\mathrm{V}_{(\mathrm{BR}) \mathrm{R}}$ | 100 | - | - | V |
| Capacitance $\text { at } \mathrm{V}_{\mathrm{F}}=\mathrm{V}_{\mathrm{R}}=0 \mathrm{~V}$ | $\mathrm{C}_{\text {tot }}$ | - | - | 4 | pF |
| Reverse Recovery Time from $I_{F}=10 \mathrm{~mA}$ to $\mathrm{I}_{\mathrm{R}}=1 \mathrm{~mA}, \mathrm{~V}_{\mathrm{R}}=6 \mathrm{~V}, \mathrm{R}_{\mathrm{L}}=100$ $\Omega$ | $\mathrm{trr}_{\text {r }}$ | - | - | 4 | ns |
| Thermal Resistance Junction to Ambient Air | $\mathrm{R}_{\text {thJA }}$ | - | - | 3501) | K/W |
| Recification Efficiency at $\mathrm{f}=100 \mathrm{MHz}, \mathrm{V}_{\mathrm{RF}}=2 \mathrm{~V}$ | $\eta_{v}$ | 0.45 | - | - | - |



[^0]
## Forward characteristics



Admissible power dissipation versus ambient temperature
For conditions, see footnote in table "Absolute Maximum Ratings"


Dynamic forward resistance versus forward current


Relative capacitance versus reverse voltage


## Leakage current

versus junction temperature


Admissible repetitive peak forward current versus pulse duration
For conditions, see footnote in table "Absolute Maximum Ratings"



[^0]:    Rectification Efficiency Measurement Circuit

